

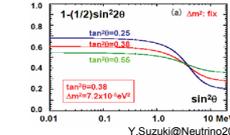
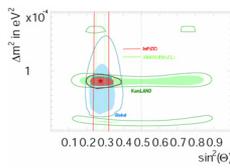
Development of InP detector for solar pp/7Be neutrino measurement

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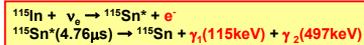
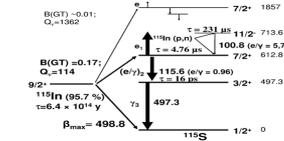
1. Introduction

- ◆ Purpose : Precise measurement of ν oscillation mixing angle θ_{12}
- ◆ Status of determination for ν oscillation parameter



◆ Technique of low energy solar neutrino detection

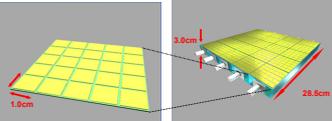
R.S.Raghavan Phys Rev Lett 37(1976)259



◆ Possible detector with 4tons of ^{115}In assuming 5 years ope.

- Number of expected events assuming no ν oscillation $\rightarrow 1885$
- Number of expected event assuming LMA solution with $E_e \geq 100\text{keV} \rightarrow 720$

Statistical and theoretical error in total $\rightarrow -3.9\%$ $\theta_{12} = 29^\circ - 34^\circ$

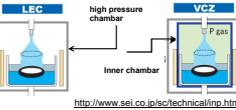


- Hybrid structure of InP and solid scintillator
- InP detector module 10mmX10mmX0.2mm cell
- Solid scintillator surrounding InP detector to detect γ s
- 4tons of ^{115}In detector for solar ν experiment
- InP : 5.1tons (2.1X10⁶ modules)
- solid scintillator (ex. CsI) : 934tons
- total size : 6.3m X 6.3m X 5.3m

2. Semi-Insulating(SI) InP semi-conductor

◆ InP crystal growth method

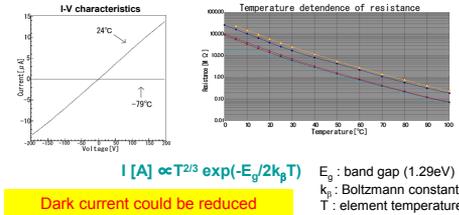
◆ VCZ (Vapor Pressure Controlled Czochralski)



- Product : Sumitomo Electric Industries, Ltd.
- Process
- In inner chamber controlled by steam pressure of As or P, covering material melt by B₂O₃ like LEC method and pulling up single crystal growth from it. Because of crystal growth in low temperature gradient, transition density can reduce.

◆ Characteristic table

EPD	~5,000cm ²
Conduct	Semi-insulation
Dopant	InP(Fe)
Resistivity	(4.9~5.2) × 10 ⁷ Ω cm
Mobility	(2.8~2.7) × 10 ³ Ω cm
Thickness	456~459μm
Diameter	50.00mm
Orientation	(100) ± 0.03°



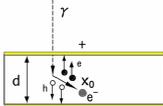
$I [A] \propto T^{2.3} \exp(-E_g/2k_B T)$ E_g : band gap (1.29eV)
 k_B : Boltzmann constant
 T : element temperature

Dark current could be reduced by lowering temperature

◆ Characteristic of SI InP semi-conductor is both target and detector

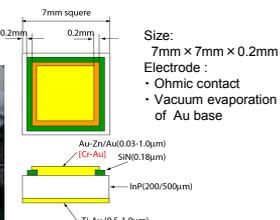
3. Test Module with the SI InP

◆ Detection of radiation with SI InP solid state detector



μ : mobility [m²v⁻¹s⁻¹]
 v : carrier velocity [ms⁻¹]
 E : electric field [vm⁻¹]
 d : thickness of SI InP
 x_0 : range of electron
 $E = V_0/d$ $v = \mu E = \mu V_0/d$
 τ : carrier lifetime [s]
 e/h creation energy : ϵ_{inh}
 $\text{charge } Q_{\text{total}}[C] = (\text{electron energy}) / \epsilon_{\text{inh}} \times e$
 $Ld \approx \infty$ $Q_{\text{obs}}[C] = \int_0^d (dE/dx) / \epsilon_{\text{inh}} e^{-\lambda(x)/Ld} dx \times e$

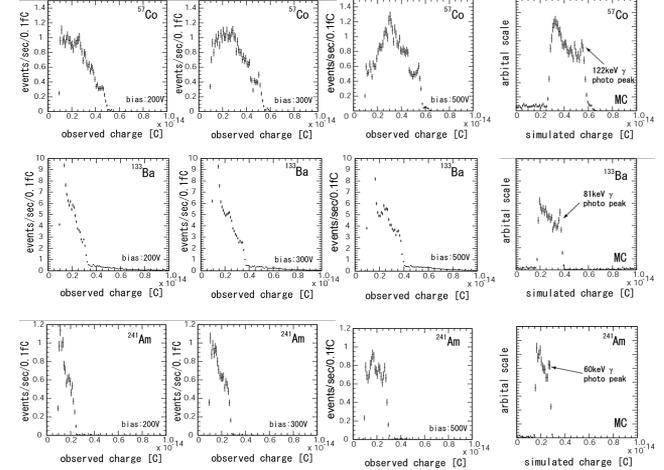
◆ InP detector with cooling dewar



Schematic view of InP detector

4. Spectrum analysis

◆ Response from ^{57}Co , ^{133}Ba and ^{241}Am



◆ γ spectrum obtained by InP detector

- Photo electric peak for 81keV (^{133}Ba), 122keV (^{57}Co) and 60keV (^{241}Am) were observed,
- However, two peaks were found,
- Higher peak corresponds to photo electric peak with charge collection efficiency (CCE) 100%.
- Average energy of electron/hole pair production is obtained by 3.5eV.
- Lower peak obtained by carrier drift is equivalent to CCE 56% (^{57}Co) and 72% (^{133}Ba), respectively
- Intrinsic energy resolution $\sigma = 5\%$ @ 122keV

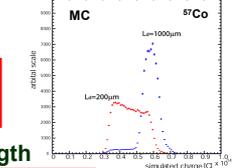
◆ Spectral analysis with MC

- Assuming charge collection due to both depletion layer formed at the ohmic contact between electrode and InP and drift of carrier in remaining region
- Input parameter : thickness of depletion layer : 30μm
- Drift length: 250μm, e/h production energy : 3.5eV
- MC reproduces spectral shape of data well

Carrier drift length L_d should be longer

◆ Low CCE signal improved by increasing carrier drift length

Assuming $L_d \sim 1000\mu\text{m}$, photo electric peak will be single peak with good energy resolution

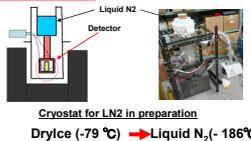
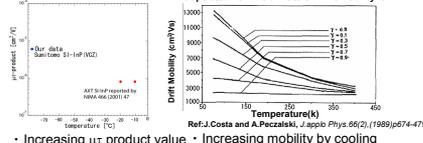


◆ How to increase the carrier drift length

1. Increasing mobility (μ)

Temperature \rightarrow lower

◆ $\mu\tau$ product value



Direct measurement of mobility using Hall Effect will be done by Semiconductor Research Institute.

2. Higher bias voltage (V_0)

Change electrode material (Au \rightarrow Pd or Ag)

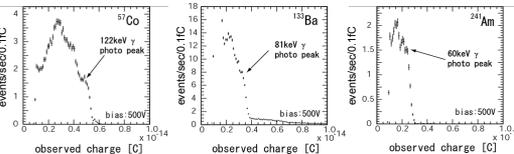
- Avoid electric noise due to dark current
- Schottky barrier height: 0.37eV(Au) / 0.41eV(Pd) / 0.54eV(Ag) Ref: J.Phys.III 1(1991) 749-758

5. Prototype detector

◆ proto-type module



◆ Response for γ -rays



- No. of Events have been increased by 3.1 times as compared with 2.8 times larger electrode area (^{57}Co).
- Effective area spread.
- Proto-type module has same performance as test module.

◆ Prototype detector for solar neutrino experiment

- proto-type detector consists of 4 modules
- Measurement of ^{115}In β -decay spectrum and bremsstrahlung in Kamioka mine
- estimate effect of accidental coincidence due to backgrounds.
- establish counting methods.
- Kyoudou-riyou program of ICRR, Univ. of Tokyo
- experiment will start at the end of this year or early of next year

